

**Notice of References Cited**

Application/Control No.

10/594,784

Applicant(s)/Patent Under  
Reexamination  
ONO ET AL.

Examiner

KARUNA P. REDDY

Art Unit

1796

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,157,083 A	10-1992	Aonuma et al.	525/285
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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**NON-PATENT DOCUMENTS**

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